



UNIFIED STRIP/CLEANING APPARATUS

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BACKGROUND OF THE INVENTION

Field of the Invention

5 The present invention relates to an apparatus of fabricating a liquid crystal display, and more particularly to a unified strip/cleaning apparatus wherein a strip device is unified with a cleaning device.

Description of the Related Art

10 Generally, since a liquid crystal display (LCD) has the advantages of small size, thin thickness and low power consumption, it has been used for a notebook personal computer, office automation equipment and audio/video equipment, etc. Particularly, an active matrix LCD using thin film transistors
15 (TFT's) as switching devices is suitable for displaying a dynamic image.

An active matrix LCD displays a picture corresponding to a video signal such as a television signal on a picture element or pixel matrix having pixels arranged at each intersection between gate
20 lines and data lines. Each pixel includes a liquid crystal cell controlling a transmitted light amount in accordance with a voltage level of a data signal from the data line. The TFT is installed at each intersection between the gate lines and the

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data lines to switch the data signal to be transmitted to the liquid crystal cell in response to a scanning signal from the gate line.

Fig. 1 shows a TFT formed on a substrate 18. A process of fabricating the TFT will be described below. First, a gate electrode 20 and a gate line is deposited on the substrate 18 with a metal such as Al, Mo, Cr or their alloy, etc. and thereafter is patterned by the photolithography. A gate insulating film 22 made from an organic material such as SiN_x or SiO_x , etc. is deposited on the substrate 18 provided with the gate electrode 20. Then, a semiconductor layer 24 made from an amorphous silicon (a-Si) layer and an ohmic contact layer 26 made from an a-Si doped with n^+ ions are continuously deposited on the gate insulating film 22. A source electrode 28 and a drain electrode 30 made from a metal such as Mo or Cr, etc. are formed on the ohmic contact layer 26. The source electrode 28 is patterned integrally with the data line. The ohmic contact layer 26 exposed through an opening between the source electrode 28 and the drain electrode 30 is eliminated by dry etching or wet etching. A protective film 32 made from SiN_x or SiO_x is entirely deposited on the substrate 18 to cover the TFT. Subsequently, a contact hole is formed in the protective film 32. A pixel electrode 34 made from an indium tin oxide (ITO) is coated so as to be connected, via the contact hole, to the drain electrode

30. Such a TFT fabricating process includes a photoresist pattern formation step, an etching step and a photoresist pattern strip step, etc. upon the patterning of the electrode layers 20, 28 and 30 or upon the formation of the contact hole.

5 Fig. 2 shows a conventional strip and cleaning apparatus. Referring to Fig. 2, the conventional strip and cleaning apparatus includes a loader 40 for loading a cassette (not shown) received with a substrate, a strip line for removing a photo-resistor (PR) of the substrate transported from the
10 cassette, a cleaning line for cleaning the stripped substrate, a dry module 54 for drying the substrate cleaned by means of the cleaning line, and a unloader 56 for loading the substrate dried by means of the dry module 54 into the cassette that is arranged in an inline type. The loader 40 carries the substrate received
15 in the cassette (not shown) into a first strip module 42 using a conveyor or a robot. The substrate from the loader 40 in which the PR formed on the TFT is removed by a pipe shower at the first strip module, is conveyed into a second strip module 44. A stripper made from a mixture of H_3PO_4 , CH_3COOH and HNO_3 is used to
20 remove the PR on the substrate. The second strip module 44 removes residual PR film that has not been removed at the first strip module 42 using a brush. The substrate having the PR film removed by physical cleaning is carried into a third strip module 46. The third strip module 46 injects the stripper at a

high pressure by a cavitation jet (CJ) system to remove the residual PR film on the substrate that has not been removed at the first and second strip modules 42 and 44. The substrate stripped at the third strip module 46 is carried into an isopropyl alcohol (IPA) injecting module 48. The IPA injecting module 48 removes minute alien substances and cleans the stripper using an IPA liquid. If the stripper and de-ionized water are mixed at a specific composition ratio, OH is produced to corrode aluminum (Al) formed on the surfaces of the source, drain and gate electrodes. Thus, the stripper is diluted with the IPA liquid so as to prevent the corrosion of aluminum. The substrate cleaned with the IPA liquid by means of the IPA injecting module 48 is carried into a first cleaning module 50. The first cleaning module 50 cleans the substrate by a pipe shower using de-ionized water and thereafter carries it into a second cleaning module 52. The second cleaning module 52 injects de-ionized water at a high pressure by the CJ system to clean the substrate. The substrate cleaned at the second cleaning module 52 is carried into a dry module 54. The dry module 54 rotates the substrate using a centrifugal force of 1800 to 2200 rpm to remove the de-ionized water. The substrate dried at the dry module is received into the cassette on the unloader 56.

Such conventional strip/cleaning equipment requires a wide installation space of 10840×1800 mm.

SUMMARY OF THE INVENTION

Accordingly, it is an object of the present invention to provide a unified strip/cleaning apparatus wherein a strip line is integrated with a cleaning line to minimize the installation
5 space.

In order to achieve these and other objects of the invention, a unified strip/cleaning apparatus according to an embodiment of the present invention includes a strip line for removing resin on a substrate; and a cleaning line provided under the strip
10 line to clean and dry the substrate.

BRIEF DESCRIPTION OF THE DRAWINGS

These and other objects of the invention will be apparent from the following detailed description of the embodiments of the present invention with reference to the accompanying drawings,
15 in which:

Fig. 1 is a section view showing the structure of a conventional thin film transistor;

Fig. 2 is a block diagram showing the configuration of a conventional strip and cleaning apparatus; and

20 Fig. 3 is a block diagram showing the configuration of a unified strip/cleaning apparatus according to an embodiment of the present invention.

DETAILED DESCRIPTION OF THE PREFERRED EMBODIMENT

Referring to Fig. 3, there is shown a unified strip/cleaning apparatus according to an embodiment of the present invention in which a strip line and a cleaning line are stacked in a two-
5 layer configuration. The present strip/cleaning apparatus includes a loader 60 for loading a cassette (not shown) received with a substrate, a strip line for removing a photo-resistor (PR) of the substrate transported from the cassette, a cleaning line for cleaning the stripped substrate, a dry module 74 for
10 drying the substrate cleaned by means of the cleaning line, and a unloader 76 for loading the substrate dried by means of the dry module 54 into the cassette. The loader 60 is mounted with a desired number of cassettes, each of which is received with a plurality of substrates. The loader 60 plays the role of
15 carrying the substrates received in the cassette (not shown) into a first strip module 62 using a conveyor or a robot. The substrate carried from the loader 60 into the first strip module 62 where the PR formed on the TFT is removed by a pipe shower is then conveyed into a second strip module 64. Then, the substrate
20 having the PR film further removed by the physical cleaning process is carried into a third strip module 66. The third strip module 66 injects a stripper at a high pressure by a cavitation jet (CJ) system to remove residual PR film on the substrate that has not been previously removed at the first and second strip

modules 62 and 64. The substrate stripped at the third strip module 66 is carried into an isopropyl alcohol (IPA) injecting module 68. The IPA injecting module 68 removes minute alien substances and cleans the stripper using an IPA liquid. The substrate cleaned with the IPA liquid by means of the IPA injecting module 68 is conveyed, via an elevator 69, into a first cleaning module 70. The first cleaning module 70 cleans the substrate by a pipe shower using de-ionized water and thereafter carries it into a second cleaning module 72. The second cleaning module 72 injects de-ionized water at a high pressure utilizing the CJ system to clean the substrate. The substrate cleaned at the second cleaning module 72 is carried into a dry module 74. The substrate cleaned at the second cleaning module 72 is carried into a dry module 74. The substrate conveyed into the dry module 74 is rotated by a centrifugal force of 1800 to 2200 rpm to remove the de-ionized water. The substrate dried at the dry module 74 is received into the cassette on the unloader 76.

As described above, the unified strip/cleaning apparatus according to the present invention is stacked to have a two-layer structure, so that the installation space can be minimized. Accordingly, the present unified strip/cleaning apparatus occupies a space of 5270 x 1800 mm that is equal to one-half of the space utilized in the prior art.

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Although the present invention has been explained by the
embodiments shown in the drawings described above, it should be
understood to the ordinary skilled person in the art that the
invention is not limited to the embodiments, but rather that
5 various changes or modifications thereof are possible without
departing from the spirit of the invention.